

RECEIVED Attorney Ref: 19944.0044

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

TO 2000 , MIL ROOM

Examiner: Unassigned

Art Unit: 2877

In re application of

Alek C. Chen

Serial No.: 09/502,062

Filed: February 10, 2000

Title: IN SITU PROXIMITY GAP MONITOR

FOR LITHOGRAPHY

Commissioner of Patents and Trademarks Washington, D.C. 20231

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TRANSMITTAL OF POWER OF ATTORNEY BY ASSIGNEE

Dear Sir:

The applicant hereby submits a Power of Attorney in the above-identified application appointing Swidler Berlin Shereff Friedman, LLP with power to prosecute the above-identified application. Please direct future correspondence and communication to Swidler Berlin Shereff Friedman, LLP as indicated in the Power of Attorney. BAE Systems Information and Electronic Systems Integration, Inc. is the assignee of the entire right, title and interest in the above-identified application by virtue of:

- A copy of the enclosed assignment from Lockheed Martin Corporation to BAE Systems Information and Electronic Systems Integration, Inc;
- 2) A copy of the Notice of Recordation of Assignment from the inventor to Lockheed Martin Corporation which has been recorded at reel 010601, frame 0598.

If any fees are due in order to enter the Power of Attorney, the Commissioner is hereby authorized to charge to Deposit Account No.19-5127, Docket 19944.0044. If you have any questions, please feel free to contact the undersigned.

Respectfully submitted,

Date: December 7, 2001

Robert C. Bertin

Registration No. 41,488

SWIDLER BERLIN SHEREFF FRIEDMAN, LLP

3000 K Street, N.W., Suite 300

Washington, D.C. 20007 (202) 424-7500

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

POWER OF ATTORNEY BY ASSIGNEE ROOM

The undersigned assignee of the entire interest in the patent applications and issued patents identified in the attached Exhibit A, by virtue of that certain assignment agreement dated November 27, 2000 by and among BAE Systems Information and Electronic Systems Integration, Inc. and Lockheed Martin Corporation, elects to conduct the prosecution of the patent applications and maintenance of the patents to the exclusion of the inventor(s) and earlier assignees.

The undersigned hereby declares that he has reviewed the above-referenced assignment and hereby declares that, to the best of his knowledge, title is in the Assignee, and further declares that all statements made herein of his own knowledge are true and that all statements made on information and belief are believed to be true. The assignee hereby revokes any previous powers of attorney and appoints the following attorneys, all of Swidler Berlin Shereff Friedman, LLP, to prosecute the patent applications and maintain the patents listed in the attached Exhibit A and transact all business in the Patent and Trademark Office connected therewith:

Edward A. Pennington	ı 32,588	John P. Moran	30,906
Michael A. Schwartz	40,161	Robert C. Bertin	41,488
Alicia A. Meros	44,937	Chadwick A. Jackson	46,495
Sean P. O'Hanlon	47,252	Eric J. Franklin	37,134

Please send all written communications to:

Edward A. Pennington Swidler, Berlin, Shereff, Friedman, L.L.P. 3000 K Street, Washington, D.C. 20007 Fax (202) 295-8478

Please direct all telephone calls to: Robert C. Bertin, 202-424-7872.

ASSIGNEE

BAE SYSTEMS INFORMATION AND ELECTRONIC SYSTEMS INTEGRATION, INC.

Date: November 15, 200

Kevin MJPerkins

Title: Vice President and Secretary-

Company General Counsel for its IEWS business





Title:	Application	J	Patent	Issue Date:
· · · · · · · · · · · · · · · · · · ·	1,200,000	1 1 A A A	Number:	
Error Detection And Fault Isolation For Lockstep Processor Systems	08/660640	07-Jun-1996	5.915,082	22-Jun-1999
Process To Personalize Master Slice Wafers And Fabricate High Density VLSI Components With A Single Masking Step	08/728880	10-Oct-1996	5,858,817	12-Jan-1999
Fault Tolerant MOSFET Driver	08/733080	16-Oct-1996	5,796,274	18-Aug-1998
Electrostatic Discharge Protection For Silicon-On-Insulator	08/812183	06-Mar-1997	6,034,399	07-Mar-2000
Ring Domains For Bandwidth Sharing	08/812184	06-Mar-1997	5,901,148	04-May-1999
Secure Data Transmission On A TDM Isochronous Network	08/837165	14-Apr-1997	5,970,095	19-Oct-1999
Digital Multi-Channel Demultiplexer/Multiplex (MCD/M Architecture)	08/864650	27-Jun-1997	5,867,479	02-Feb-1999
Control And Telemetry Signal Communication System For Geostationary Satellites	08/884675	27-Jun-1997	6,188,87481	13-Feb-2001
Shallow Isolation Trench Forming Process For Silicon-On-Insulator Technology	08/987016	09-Dec-1997		
Reversible Keypad And Display For A Telephone Handset	08/989463	12-Dec-1997	6.052.606	18-Apr-2000
Integrated Circuit Package And Method Increasing Density Of I/O Leads	09/007980	16-Jan-1998		
Multi-Channel Overvoltage Protection Circuit	09/030902	26-feb-1998	6.127,879	03-Oct-2000
Digital Multi-Channel Demultiplexer/Multiplexer (MCD/M) Architecture	09/241313	01-Feb-1999	6,091,704	18-Jul-2000
Error Detection And Fault Isolation For Lockstep Processor Systems	09/325641	04-Jun-1999	6,065,135	16-May-2000
Radiation Hardened Six Transistor Random Access Memory And Memory Device	09/325645	04-Jun-1999	6,111,780	29-Aug-2000
Satellite Telephone Handset	09/384429	27-Aug-1999		
Enhanced Single Event Upset Immune Latch Circuit	09/480454	11-Jan-2000	6,275,080	14-Aug-2001
In Situ Proximity Gap Monitor For Lithography	09/502062	10-Feb-2000		TARREST AND
Method And Apparatus For A Single Event Ups_t (SEU) Tolerant Clock Splitter	09/559659	28-Apr-2000		Parids on Assessment
Method And Apparatus For A Scannable Hybrid Flip Flop	09/559660	28-Apr-2000		
Method And Apparatus For A SEU Tolerant Clock Splitter	09/559661	28-Apr-2000		

PAGE: 04/04

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				<u>5-11</u>
Title:	Application Number:	Filing Date:	Patent Numb r:	Tissue Date:
Distributed Determination Of Explicit Rate In An ATM Communication System	09/570050	12-May-2000	1020-2103	L ROOM
Self-Equalized Low Power Precharge Sense Amp For High Speed SRAMs	09/570064	12-May-2000		
Tool Suite For The Rapid Development Of Advanced Standard Cell Libraries	09/597229	20-Jun-2000		
Digital Multi-Channel Demultiplexer/Multiplexer (MCD/M) Architecture	09/625641	25-Jul-2000		9,179.12
Elimination Of Narrow Device Width Effects In Complementary Metal Oxide Semiconductor (CMOS) Devices	09/741028	21-Dec-2000		
Ball Grid Array (BGA) To Column Grid Array (CGA) Conversion Process	09/774010	31-Jan-2001		
Polyphase-Discrete Fourier Transform (DFT) Sub-band Definition Filtering Architecture	09/780348	12-Feb-2001		
Method And Apparatus For A Radiation Hardened Clock Splitter	09/838131	20-Apr-2001		

PATENT ASSIGNMENT

THIS PATENT ASSIGNMENT is made and entered into as of the 27th day of November 2000, between Lockheed Martin Corporation, a Maryland corporation ("Assignor"), and BAE SYSTEMS INFORMATION AND ELECTRONIC SYSTEMS INTEGRATION INC. (formerly known as BAE SYSTEMS Sanders Inc.), a Delaware corporation ("Assignee").

WITNESSETH:

WHEREAS, Assignor is the owner of the entire right, title and interest in and to all of the patents and patent applications set forth on Schedule A annexed hereto and made a part hereof and has the unrestricted right to sell, assign and transfer such patents and patent applications; and

WHEREAS, pursuant to the terms of a Transaction Agreement, dated as of July 13, 2000, by and among Assignor, Assignee and BAE SYSTEMS North America Inc., a Delaware corporation, Assignor has agreed, among other things, to transfer to Assignee said patents and patent applications;

NOW. THEREFORE, in consideration of the sum of ten (\$10.00) dollars and other good and valuable consideration paid by Assignee to Assignor, the receipt and sufficiency of which is hereby acknowledged, Assignor hereby sells, assigns, transfers and sets over to Assignee, its successors and permitted assigns, Assignor's entire right, title and interest in and to the patents and patent applications set forth on Schedule A hereto, including (without limitation) all divisions, reissues, substitutions, continuations and extensions thereof, all priority rights under the International Convention for the Protection of Industrial Property for every member country (and any other international convention or treaty), any and all Letters Patent and reissues and extensions of Letters Patent granted thereon and any and all rights corresponding to any of the foregoing throughout the world and any and all accounts, contract rights, warranties, litigation claims and rights, including the right to sue for and collect upon all claims for profits and damages as a result of past infringement, if any, and other general intangibles of Assignor related to any of the foregoing, in each case whether now existing or hereafter acquired or created, whether owned, leased or licensed beneficially or of record and whether owned, leased or licensed individually, jointly or otherwise, together with the products and proceeds thereof (including license royalties and the proceeds of infringement suits), all payments and other distributions with respect thereto and any divisions, reissues, substitutions, continuations and extensions of any and all of the foregoing (all of the foregoing herein collectively referred to as the "Patents").

Assignor further agrees that it shall on the date hereof and from time to time thereafter, at the request of Assignee, perform or cause to be performed such acts and execute, acknowledge and deliver at the request of Assignee, such documents as may reasonably be required to evidence or effectuate the sale, conveyance, assignment, transfer and delivery to Assignee of the Patents or for the performance by Assignor of any of its obligations hereunder.

IN WITNESS WHEREOF, Assignor has executed this Patent Assignment as of the date above written.

LOCKHEED MARTIN CORPORATION

BAE SYSTEMS INFORMATION AND ELECTRONIC SYSTEMS INTEGRATION INC.

Title: Vice Proydent

DISTRICT OF COLUMBIA ss.:

On the 27 day of November, 2000, before me personally cam Worren W. Lahring, to me known (or satisfactorily proven), who being by me duly sworn, did depose and say that he is the Director, Buriness Verfueso Lockheed Martin Corporation, the corporation described in, and which executed the foregoing instrument, and that he was fully authorized to execute this Patent Assignment on behalf of said corporation.
Notary Public My
DISTRICT OF COLUMBIA ss.:
On the day of November, 2000, before me personally came to me duly swom, did depose and say that he is the Vice Remainstance of the same support o

SCHEDULE A

LM Space Electronics & Communications

CaseNumber Title	r Tide)	Country Status	Status	File Date	File Date AppliNumb	Issue Date	Issue Date PatNumber
FE-00003	High Dens	High Density Integrated Circuit						
			us	Expired	24-Jan-1979	5946	17-Jun-1980	4,208,079
			رار	Abandone	20-Dec-1979	164876/79	20-Jan-1984	1185552
FE-00006	Process fo	Process for Increasing the Immunity of IC to lonizing Radiation	ing Radia	tion				
			NS	Secret	28-Jun-1982	393,012	,	
FE-00007	FET Read	FET Read Only Memory Cell With Work Line Augmented Precharging Of Bit Lines	mented Pi	recharging (J Bit Lines			
			G,	Abandone	15-May-1984	095787/84	10-Nov-1988	1464935
			CB	Granted	24-Jul-1984	84108711.7	27-Sep-1989	0135699
			FR	Granted	24-Jul-1984	84108711.7	27-Sep-1989	0135699
			۸ĭ	Granted	24-Jul-1984	084108711.7	27-Sep-1989	0135699
			กร	Granted	20-Sep-1983	534,035	16-Feb-1988	4,725,986
			DE	Granted	24-Jul-1984	084108711.7	27-Sep-1989	0135699
			EP	Granted	24-Jul-1984	84108711.7	27-Sep-1989	0135699
FE-00008	Improved	Improved Local Oxide Isolation Process			٠			
			Sn	Secret	06-Jul-1984	643,902		

CaseNumber Title	r Title	Country Status	Status	File Date	File Date ApplNumb	Issue Date	PatNumber	
FE-00009	High Density, High Performance, Single Event Upset Immune Data	Jpset Immu	2				•	
		NS	Granted	09-Mar-1987	23,426	10-Jan-1989	4,797,804	
		FR	Granted	22-Jan-1988	88100947.6	13-Jan-1993	281,741	
		Ę,	Granted	20-Jan-1988	008597/88	07-Oct-1994	1878682	
		EP	Granted	22-Jan-1988	88100947.6	13-Jan-1993	281,741	
		89	Granted	22-Jan-1988	88100947.6	13-Jan-1993	281,741	
		SE SE	Granted	22-Jan-1988	88100947.6	13-Jan-1993	3877381308	
FE-00010	Parity Generator Circuit And Method				,			
		EP	Pending	23-Jan-1989	89101069.6	•		
		Sn	Granted	17-Feb-1988	156,626	07-Nov-1989	4,879,675	
		d۲	Lapsed	18-Nov-1988	290385/88	14-Oct-1992	1703279	
FE-00012	Sofi Error Resistant CMOS Data Cells							
		SN	Granted	31-Mar-1988	176,052	25-Jul-1989	4,852,060	
		CO	Lapsed	23-Dec-1988	88121619.6	10-Jun-1992	335,008	
		ď	Pending	20-Feb-1989	38541/89			
		DE	Lapsed	23-Dec-1988	88121619.6	10-Jun-1992	3871945208	
		FR	Lapsed	23-Dec-1988	88121619.6	10-Jun-1992	355,008	
FE-00016	Process for Increasing the Immunity of IC to Ionizing Radiation	nizing Radio	nion				_	_
		SN	Secret	13-Sep-1988	246,136			

Circuit	Country State Zero Standby Power, Radiation Hardened, Memory Redundancy	Country Status vy Redundancy	File Date	File Date ApplNumb	Issue Date	PatNumber
	EP	Granted	03-May-1990	90108357.6	21-Aug-1996	419,760
	DE	Granted	03-May-1990	90108357.6	21-Aug-1996	69028169.2
	٩	Granted	07-Sep-1990	236022/90	17-Dec-1999	3015084
	SN	Granted	26-Sep-1989	414,889	26-Feb-1991	4,996,670
	69	Granted	03-May-1990	90108357.6	21-Aug-1996	419,760
	FR	Granted	03-May-1990	90108357.6	21-Aug-1996	419,760
	MO	Pending	09-Sep-1990	236022/90		
FE-00020 — A Method for improving gate oxide reliability of	etiability of SOI in Me	SOI in Mesa Type Transistors.	msistors.		ť	
	SO	Secret	13-Jun-1990	544,140		
FE-00021 CAIOS Off Chip Driver for Fault Tolerant Cold Sparing	lerant Cold Sparing					
	EP	Granted	08-Oct-1991	91117104.9	28-Feb-1996	481,329
	٩٢	Granted	11-Oct-1991	290475/91	08-Aug-1996	2549221
	DE	Granted	08-Oct-1991	91117104.9	28-Feb-1996	69117420.2
	FR	Granted	08-Oct-1991	91117104.9	28-Feb-1996	481,329
	SN	Granted	16-Oct-1990	598,300	26-May-1992	5,117,129
	68	Granted	08-Oct-1991	91117104.9	28-Feb-1996	481,329
FE-00022 Method of Forming A frontside Contact to the Silicon Substrate of a SOI Wafer	tact to the Silicon Subs	strate of a Se	OI Wafer			
	ď	Granted	28-Mar-1994	057624/94	02-Dec-1996	2589952
FE-00029 Small Cell Low Contact Assistance Rugged Power Field Effect Devices And Method Of Fabrication	Rugged Power Field E	Hert				
	NS	Granted	03-Feb-1992	829,667	10-Aug-1993	5,234,851
Tuesday, November 21, 2000						Page 3 of 20
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CaseNumber Title	ı	Country Status	Status	File Date	File Date ApplNumb	Issue Date	Issue Date PatNumber	
FE-00031	Distributed Programmable Priority Arbitration							
			Granted	01-Mar-1993	39810/93	27-Jun-1996	2531918	
	SU		Granted	30-Apr-1992	676,239	26-Apr-1994	5,307,466	-
FE-00035	Fast Fourier Transform Using Bulanced Coefficients							
	g.	•	Granted	22-Oct-1991	301336/91	13-Jun-1997	2662124	
	EP		Pending	13-Jun-1991	91109688.1			
	SN .		Granted	13-Jan-1993	004,217	15-Nov-1994	5,365,469	
FE-00040	An Electrostatic Discharge Protect Diode For Silicon-On- Insulator Technology	n-0n-				,		
	df .	•	Granted	28-Mar-1994	6-57668/94	09-May-1997	2647339	
	30	ш	Granted	17-Feb-1994	94102415.0	21-Apr-1999	0622850	
	FR	ď	Granted	17-Feb-1994	94102415.0	21-Apr-1999	0622850	
	EP	۵	Granled	17-Feb-1994	94102415.0	21-Apr-1999	0622850	
	89	æ	Granted	17.Feb-1994	94102415.0	21-Apr-1999	0622850	
	SN .	S	Abandone	30-Apr-1993	056,042			
FE-00041	Method To Prevent Latch-Up And Improve Breakdown Voltage In SOI Mosfets	vn Volta	อธิ					
	Ī	EP	Pending	17-Feb-1994	94102414.3			
	SN	S	Granted	12-Sep-1994	304,639	18-Jun-1996	5,527,724	

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CaseNumber Title		Country S	Status	File Date	File Date ApplNumb	Issue Date	PatNumber	
FE-00042	A Method Of Forming A Frontside Contact To the Silicon Substrate Of A SOI Wafer	icon			:			
	SN		Granted	30-Apr-1993	054,992	24-May-1994	5,314,841	
	30		Pending	17-Feb-1994	94102416.8		-	-
	EP		Pending	17-Feb-1994	94102416.8			
	df		Granted	18-Apr-1994	078654/94	26-Feb-1999	2891321	
	89		Pending	17-Feb-1994	94102416.8			
	FR		Pending	17-Feb-1994	94102416.8			
FE-00052	Power Bus Digital Communication System							
	sn		Granled	04-Oct-1993	131,346	01-Jul-1997	5,644,286	
FE-00057	Single Even Upset Hardening Of Commercial VI.SI Technology Without Circuit Redesign	golondos	y Without	Circuit Redes	ign			
	SN .		Pending	26-Oct-1993	141,505			
	dt .		Abandone	19-Oct-1994	6-253600			
	EP .		Pending	30-Aug-1994	94113502.2			
FE-00060	Method To Radiation Harden The Buried Oxide In Silicon-On-Insulator Structures							
	SN		Granted	28-Oct-1993	142,030	01-Nov-1994	5,360,752	
	EP		Granted	14-Oct-1994	94116233.1	22-Dec-1999	652591A1	
FE-00069	Spare Signal Line Switching Method and Apparatus							-
	SU		Granted	14-Mar-1994	212,372	05-Sep-1995	5,448,572	
	qu		Granted	26-Jun-1992	168828/92	21-Nov-1996	2113094	
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CaseNumber Title FE-00070 Gate Devis	er Tide Gate Over Devices	Title Gate Overlapped Lightly Daped Drain Far Buried Channel Devices	Status	File Date	File Date ApplNumb	Issue Date PatNumber	PatNumber
		85	Granted	26-May-1994	94108054.1	29-Nov-1995	0684640
		SN	Granted	30-Apr-1993	054,994	25-Oct-1994	5,358,879
		FR	Granted	26-May-1994	94108054.1	29-Nov-1995	684640
		ď	Granted	04-Jun-1994	6-127422	19-Sep-1997	2698046
		DE	Granted	26-May-1994	94108054.1	29-Nov-1995	0684640
		EP	Granted	26-May-1994	94108054.1	10-Nov-1999	0684640
FE-00071	Current C	Current Overload Protection Circuit				•	
		SN	Granted	12-Jan-1995	371,718	10-Oct-1995	5,457,591
FE-00072	Single Ev	Single Event Upset Hardened CMOS Latch Circuit					
		SN	Granted	01-Feb-1995	382,112	02-Apr-1996	5,504,703
FE-00073	Magnificatio Lithography	Magnification Correction For 1-X Proximity X-Ray Lithography					
		SN	Granled	17.Feb-1995	389,993	02-Apr-1996	5,504,793
FE-00074	Single Ev	Single Event Upset Immune Register With Fast Write Access	<i>S</i> 3				
		Sn	Granted	21-Feb-1995	391,798	11-Jun-1996	5,525,923

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CaseNumber Title	er Title	Country Status	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00075	Checkpoint Retry Mechanism						
		ns	Abandone	23-Aug-1988	235,345	27-Mar-1990	4,912,707
		چ	Abandone	11-Aug-1989	0207115	07-Apr-1995	1922412
		СВ	Abandone	. 08-Jun-1989	89110329.3	13-Aug-1995	0355286
		DE	Abandone	08-Jun-1989	89110329.3	13-Aug-1995	0355286
		FR	Abandone	08-Jun-1989	89110329.3	13-Aug-1995	0355286
		ЕР	Abandone	08-Jun-1989	89110329.3	13-Aug-1995	0355286
FE-00090	Efficient Dual Source Fault Tolerant Power Controller	roller					
		ns	Granted	16-Nov-1995	559,584	28-Jan-1997	5,598,041
FE-00091	A Scaleable, Radiation Hardened Shallow Trench Isolation	ı Isolation					
		SN	Abandone	01-Jul-1999	60/142,035		
		NS	Pending	30-Jun-2000			
FE-00092	Apparatus And Method For Cooling Standard Electronic Modules	ectronic					
		Sn	Abandone	19-Jan-1996	588,804		
FE-00101	Error Detection and Fault Isolation For Lockstep Processor Systems	Processo.	r Systems				
		Sn	Granted	07-Jun-1996	660,640	22-Jun-1999	5,915,082
		Sn	Granted	04-Jun-1999	325,641	16-May-2000	6,065,135
FE-00107	X-Ray Mask Pellicle						
		Sn	Granted	06-Sep-1996	716,657	11-Aug-1998	5,793,836

CaseNumber Title FE-00113 Proc	r Tide Country Status Process To Personalize Master Slice Wafer And Fabricate High Density VI St Components With A Simbo Machine Sea	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00114	Fault Tolerant MOSFET Driver	Granted	10-Oct-1996	728,880	12-Jan-1999	5,858,817
FE-00115	US G Lithographic Patterning Afethod And Mask Set Therefor With Light Field Trim Mask	Granted it/I	16-Oct-1996	733,080	18-Aug-1998	5,796,274
FE-00121	US Ring Domains For Bandwidth Sharing	Granled	31-Oct-1996	740,598	15-Sep-1998	5,807,649
FE-00122	us c Electrostatic Discharge Protection For Silicon-On-Insulation	Granted ion	06-Mar-1997	812,184	04-May-1999	5,901,148
FE-00124	US Dual Mode Telephone Handset Satellite Telephone Handset -	Granted	06-Mar-1997	812,103	07-Mar-2000	6,034,399
FE-00124-1	US FE-00124-1 Satellite Telephone Handset	Granled	27-Mar-1997	29069642	28-Sep-1999	D414,486
FE-00126	US Secure Data Transmission on A TDM Isachronous Network	Pending k	27-Aug-1999	384,429		
	Sn	Granled	14-Apr-1997	837,165	19-Oct-1999	5,970,095

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CaseNumber Title FE-00130 Impr	oved Control Telemetry Signal Communicati	Country Status m System For Ge	Status For Geostati	File Date ionary Satelli	File Date ApplNumb ry Satellites	Issue Date	PatNumber
		SN	Pending	27-Jun-1997	884,675		
		SN	Pending	23-Dec-1999	884,675		
FE-00131	Digital Multi-Channel Demultiplexer/Multiplexer (MCD/M) Architecture	(MCD/M)					
		NS	Pending	25-Jul-2000	625,641		
		ns	Granled	27-Jun-1997	884,650	02-Feb-1999	5,867,479
		NS	Granled	01-Feb-1999	241,313	18-Jul-2000	6,091,704
FE-00144	Dual Mode Collision Avoidance System				٠		
		SN	Abandone				
FE-00165	Radiation Hardened Six Transistor Random Access Memory and Memory Device	ss Memory	and Memor	y Device			
		ns	Abandone	04-Jun-1998	090,946		
		Sn	Granted	05-Jun-1999	325,645	29-Aug-2000	6,111,780
		WO	Pending	04-Jun-1999	US99/12442		
FE-00170	Enhanced TRENCH Isolation (STI) Method for Fabricating Radiation-Tolerant Integrated Circuit Devices.	abricating	Radiation-7	olerant Integr	rated Circuit De	evices.	
		ns	Pending	30-Jun-2000	512,671		
FE-00172	High Accuracy Fabrication Of X-Ray Masks With Optical And E-Beam Lithography	Optical A	nd.				
		SN	Granted	04-Jun-1996	663,826	26-May-1998	5,756,234
FE-00185	Integrated Circuit Package and Method Increasing Density Of 1/0 Leads	ng Density	Of I/O Lead	بئ			
		SO	Pending	16-Jan-1998	086,700		

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Caselvitmber 1 ille FE-00221 Distr	ibuted Determination of Explicit Rate in an 1	Country Status TM Communication	File Date System	File Date ⁻ ApplNumb m	Issue Date	PatNumber	
FE-00228 Eli	US Expired 03-Jun-1999 60/137,595 US Expired 19-Oct-1999 60/160,302 US Pending 12-May-2000 570,050 Elimination of Narrow Device Width Effects In Complementary Metal Oxide Semiconductor (CMOS) Devices	Expired Expired Pending	03-Jun-1999 19-Oct-1999 12-May-2000 Oxide Semicom	60/137,595 60/160,302 570,050 ductor (CMO.S)) Devices		-
FE-00233 Re	US Reversible Keypad And Display For A Telephone Handset	Unlited					
FE-00239 Re	us Recessed Gate Process For Silicon-On-Insulator Devices	Granted	12-Dec-1997	989,463	18-Apr-2000	6.052,606	
FE-00258 Sh	US Abandone 04-Nov-1 Shallow Isolation Trench Forming Process For Silicon-on-Insulator Technology	Abandone m-Insulator To	04-Nov-1997 echnology	964,022			
FE-00275 Co	US Pending 09-Dec-1 Cold Spare and Voltage Interoperable Off-Chip Driver and Associated Methods	Pending Ind Associated	09-Dec-1997 I Methods	987,016			
F.E-00276 Se	US Pending 05 US Expired 02 Self Equalized Low Power Precharge Sense AMP For High Speed Memory	Pending Expired igh Speed Men	05-May-2000 02-Jun-1999 mory	566,17 <i>8</i> 60/137,174			
	sn ·	Pending Expired Expired	12-May-2000 10-Feb-2000 01-Jun-1999	570,064 60/181,559 60/137,224		٠	·
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CaseNumber Title	er Title	Country Status	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00277	A Memory Device Having Reduced Power Requirements And Associated Methods	rements An	d Associate	l Methods	• •		
FE-00278	US Pending 26-May-199 A Memory Device Having A Chip Select Speedup Feature and Associated Methods	US Feature a	Pending nd Associate	26-May-1999 ed Afethods	320,227		
FE-00279	US Pending Single Event Upset Hardened CMOS Latch Circuit With Fast Write Time	US uir With Fa	Pending st Write Tim	26-May-1999 1 <i>e</i>	320,207		
FE-00291	Multi-Channel Overvoltage Protection Circuit	Sn	Abandone	07-Oct-1998	168,430	,	
FE-00295	US Granted 26-Feb-1998 Method For Fabricating Resistors Within Semiconductor Integrated Circuit Devices	US onductor In	Granted Itegrated Cii	26-Feb-1998 rcuit Devices	030,902	03-Oct-2000	6,127,879
FE-00300	In Situ Proximity Gap Monitor For Lithography	us us	Pending Expired	25-Jan-2000 01-Fcb-1999	491,230		
FE-00319	US Pending 10-Feb-2000 502,062 US Expired 24-Sep-1999 60/155,571 Enhanced Local Oxidation of Silicon (LOCOS) Method for Fabricating Radiation-Tolerant Integrated Circuit Devices	us us Method for	Pending Expired Fabricating	10-Feb-2000 24-Sep-1999 Radiation-Tol	502,062 60/155,571 lerant Integrate	d Circuit Devi	s s s s
		sn	Unfiled				
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Issue Date		
File Date ApplNumb Jan-2000 480,454 Jan-2000 US00/00557 Jul-1999 60/145,939	441,941 US99/27302 US99/27302 US99/27302 US99/27302 60/136,480	60/139,897 60/131,926 559,661 559,660 US00/11348 60/132,121
File Date 11-Jan-2000 11-Jan-2000 28-Jul-1999	17-Nov-1999 17-Nov-1999 17-Nov-1999 17-Nov-1999 28-May-1999	22-Jun-2000 22-Jun-1999 30-Apr-1999 28-Apr-2000 28-Apr-2000 30-Apr-1999
Status Pending Pending Expired	Pending Pending Pending Pending Pending Abandone	Pending Expired Pending Pending Expired Expired
Title Country Status File Date ApplNumb Enhanced Single Event Upset Immune Latch Circuit US Pending 11-Jan-2000 480,454 WO Pending 11-Jan-2000 US00/00557 US Expired 28-Jul-1999 60/145,939	US Pending 17-Nov-1999 441 US Pending 17-Nov-1999 US GB Pending 17-Nov-1999 US FR Pending 17-Nov-1999 US EP Pending 17-Nov-1999 US US Abandone 28-May-1999 601	US US Method and Apparatus for a SEU Tolerant Clock Splitter US US US WO US US WO US
CaseNumber Title FE-00320 Enhanced Si FE-00321 Method and		FE-00352 Method and FE-00354 Method and Tuesday, November 21, 2000

CaseNumber Title	r Title	Country Status	Status	File Date	File Date ApplNumb	Issue Date	Issue Date PatNumber
FE-00371	Pattern Density Tailoring For Etching of Advanced Lithographic Masks	ed Lithogra	uphic Masks		-		
		ns	Pending	07-May-1999	307,126		
FE-00372	Method and Apparatus For Evaluating A Known Good Die Using Both Wire Bond and Flip-Chip Interconnects	Good Die	Jsing Both 1	Vire Bond and	Flip-Chip Inte	гсоннестя	
		Sn	Pending	28-May-1999	321,565		
FE-00375	Single-Event Upset Hardened Reconfiguration Bi-Stable CMOS Latch	-Stable CA	tOS Latch				٠
		wo	Pending	20-Jan-2000	US00/01356		
		Sn	Pending	24-Nov-1999	449,723	•	
		Sn	Abandone	23-Dec-1999	60/171,589		
FE-00385	Method and Apparatus for a Voltage Rexponsive RESET for EEPROM	RESET for	EEPROM				
		SN	Pending	02-May-2000	563,197		
		SN	Expired	02-Jun-1999	60/137,739		
FE-00387	Low-Power CMOS Device and Logic Gates/Circuits Therewidth	nits Therev	ridth				
		WO	Pending	22-Jun-2000	US00/11887		
		SN	Expired	09-Nov-1999	60/164,343		
		SN	Expired	23-Jun-1999	60/140,361		
		ns	Pending	21-Jun-2000	598,681		

CaseNumber Title	r Tide	Country Status	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00391	Single Event Upxet (SEU) Hardened Static Random Access Memory Cell	m Access I	demony Cell				
		กร	Expired	28-May-1999	60/136,479		
		ns	Pending	17-Nov-1999	441,942		
		Sn	Pending	30-Aug-2000	651,155		
		ЕР	Pending	17-Nov-1999	US99/27301		
FE-00397	Circuit and Method For Limiting Inrush Current Through A Mosfet Circuit and Method For Limiting Inrush Current Through A Transistor/102	Through A Through A	Mosfet Transistor/1	02			
		SN	Expired	30-Dec-1999	60/174,059		
		wo	Unfiled				
		SO	Pending	12-Jun-2000	591,958		
FE-00398	Integrated Resistor Having Aligned Body and Contact and Method for Forming The Same	ntact and A	tethod for Fa	orming The Sc	ımc		,
		SN	Provision	21-Jan-2000	60/178,247		
FE-00406	Storage Unit Subassembly Insertion/Extraction Tool	poo					
		ns	Expired	17-Feb-1999	60/120,328		
FE-00410	Computer Device Having Multiple Linked Parallel Busses and Associated Method	el Busses a	nd Associate	d Method			
		SN	Pending	14-Sep-2000			
FE-00414	Self-Restoring Single Event Upset (SEU) Hardened Multiport Memory Cell	ed Multipo	rt Memory C	ell			
		กร	Expired	28-May-1999	60/136,478		
		wo	Pending	15-May-2000	US00/13095		
		SN	Pending	20-Apr-2000	553,595		

CaseNumber Title FE-00422 Syste	m and Method of Providing a Spread Spectr	Country Status um Pulse Width A	Status Vidth Modul	File Date lator Clock	File Date ApplNumb • Clock	Issue Date	PatNumber
		OM	Expired Pending	18-Oct-1999 12-Am-2000	60/159,974 USaa/28748		
FE-00424	US Pending 12-Multiplexor Having A Single Event Upset (SEU) Immune Data Keeper Circuit	us mune Da	Pending Ia Keeper (12-Jun-2000 Treuit	-591,731		·
FE-00426	US Pending 08-Jun-2000 Oscillator and Method For Generating A frequency Within A Stable Frequency Range	us · <i>Widhin</i> z	Pending I Stable Fre	08-Jun-2000 дисису Канце	589,732		
FE-00431	Method For Testing Known Good Die	Sn	Provision	05-Nov-1999	60/163,757		
FE-00432	US Pending 24-Jul US Expired 25-Oc Method and Apparatus for a Single Event Upset (SEU) Tolerant Clock Splitter	us us ?:U) Tolei	Pending Expired ''ant ('lock S	24-Jul-2000 25-Oct-1999 plitter	624,24 <i>7</i> 60/161,418		
		us WO US	Expired Pending Pending	30-Apr-1999 28-Apr-2000 28-Apr-2000	60/131,925 US00/11349 559,659		
FE-00434	Tool Suite for the Rapid Development of Advanced Standard Cell Libraries	Standara us	l Cell Librar Pendina	ries 20. tun.2000	597 229		
FE-00436	A Process For Removing A Silicon-Containing Material Through Use Of A Byproduct Generated During Formation Of A Diffusion Barrier Layer	erial Th	ongh Use O	Y A Byproduct	Generated Du	ring Formation	n Of A

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CaseNumber Title FE-00439 Incre	Country Status Increasing The Susceptability Of Integrated Circuits To Ionizing Radiation	Country Status uits To Ionizing Re	Status izing Radia		File Date ApplNumb	Issue Date	PatNuı
FE-00442	US Expired 11-Ju US Pending 09-Ju Semiconductor Circuit Having Increased Susceptibility To Ionizing Radiation	US US ntibility To	Expired Pending Jonizing Ra	11-Jun-1999 09-Jun-2000 <i>liation</i>	60/138,718 590,805		
FE-00443	US Pending 09-Jun-2 US Expired 11-Jun-11 Semiconductor Device And Circuit Having Low Tolerance To Ionizing Radiation	us us Tolerance	Pending Expired To Ionizing	09-Jun-2000 11-Jun-1999 Radiation	592,4-3 60/138,720		
FE-00444	US Pending US Expired Apparatus And Method For Manufacturing A Semiconductor Circuit	US US miconducte	Pending Expired or Circuit	09-Jun-2000 11-Jun-1999	590,806 60/138,721		
FE-00449	US Pending 09-Jun-2000 Method to Harden Shallow Trench Isolation Against Total Ionizing Dose Radiation	US ainst Total	Pending Ionizing Do.	09-Jun-2000 se Radiation	590,809		
FE-00450	US Pending 31-Jul-2000 US Expired 02-Aug-1999 601 A New Radiation-Hardened Technique For Preventing Latches From Single Event Upsets	US US venting Lat	Pending Expired ches From S	31-Jul-2000 02-Aug-1999 ingle Event Up	60/146,895 xels	·	
FE-00451	U Radiation Hardened High Speed Differential Driver	บร พิยา	Provfiled	11-Aug-2000	60/224,649		
		Sn	Expired	20-Jul-1999	60/144,731		
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CaseNumber Title FE-00453 Radi	Com Radiation Hardened High Speed Differential Receiver	Country Status iver	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00456	US Expired 20-Jul-1999 Radiation Hardened Silicon-On-Insulator (SOI) Transistor Having A Body Contact	US Tansistor 1	Expired Having A Boo	20-Jul-1999 ly Contact	60/144,625		
		SD NS	Pending Explied	01-Aug-2000 23-Dec-1999	630,216		
F.E-00458	Circuit For Filtering Single Event Effect (SEE) Induced Glitches	nduced Gli	iches				
		Sn	Pending	30-Aug-2000	651,156	٠	
		SN	Expired	07-Sep-1999	60/152,348		
		WO	Pending	06-Sep-2000	US00/24421		٠
FE-00462	Method and Apparatus Radiation Hardened Clock Splitter	k Splitter					
FE-00464	Single Event Upset Immune Oscillator Circuit	SO	Provision	28-Apr-2000	60/200,348		
FE-00469	US Pending Redundant Oscillator and Method For Generating A Regulated Signal	US g A Regula	Pending uted Signal	21-Sep-2000	667,040		
FE-00470	US Pending Controlled Hermetic Solder Sealing For Large Perimeter Components	US erimeter (Pending omponents	10-Aug-2000	636,125		
		SN NS	Abandone Expired	20-Jan-2000 18-Jan-2000	60/177,234 60/176,574		÷

CaseNumber Title FE-00471 Integ	r Title Country Status File Date Integrated Circuits Containing Transistors Operable With Two Power Supply Voltages	Country Status the With Two Pow	Status wo Power Su	File Date .	File Date ApplNumb ly Voltages	Issue Date	PatNumber
FE-00475	Voltage Step-Up Output Buffer With Low Stress	sn us	Unfiled	11-Aug-2000	60/224,650		
FE-00476	U Structured Login After Satellite Service Interruption	sn	Expired	30-May-2000	60/207,913		
FE-00480	Self-Oscillating Switching Regulator	SN	Expired	18-Jan-2000	60/176,606	•	
FE-00481	A Radiation Tolerant Storage Array Sense Latch	NS	Pending	03-Oct-2000	÷		
FE-00483	US Polyphase-DFT Sub-band Definition Filtering Architecture	US chitecture	Proviiled	11-Aug-2000	60/224,648		
FE-00486	US Provision Use of Chalcogenide For Programming Fuses In RAM's or Other Devices	US RAM's or	Provision Other Devices	11-Feb-2000 s	60/181,512		
FE-00489	Direct Chip Attach Micro-CGA	NS	Provision	02-May-2000	60/201,122		
		Sn	Unfiled				,

CaseNumber Title FE-00491 Rad	er Title Rad Hard Ring Oscillator	Country Status	Status	File Date	File Date ApplNumb	Issue Date	PatNumber
FE-00492	Single Event Upset Immune Logic Family	NS N	Unfiled				
FE-00498	US Provisi US Unlitee A Sense Amp Scheme Hardened for Dynamic Single Event Upsets	US US gle Event l	Provision Unfiled Jpsets	12-May-2000	60/203,895		
FE-00503	Remote Pictures	US	Provision	06-Jun-2000	60/209,665		
FE-00505	Reduced Stress Interface Column Grid Array	Sn	Unfiled				
FE-00508	Remote Sonar Buoys	Sn	Unfiled				
FE-00512	Method For Advanced Fill Pattern Creation	Sn	Unfiled			·	
FE-00513	us Power Conservation Circuit Using The "Seebeck" liffect	us (" Effect	Unfiled				
		sn	Unfiled				
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CaseNumber Title FE-00515 Meth	er Title Method Of Forming and Applications of Micropipes and Chalcogenide Waveguides	Country Status ees and Chaleoger	Status alcogenide W	File Date ApplNumb aveguides	ppiNumb	Issue Date	PatNumber
FE-00516	Fault Isolation Test Methodology	Sn	Unfiled				
FE-00521	US Unliled Novel High-Density High-Performance CMOS SRAM Cell Design	US VAM Cell I	Unfilled Design				
FE-00522	US Unlited Novel CMOS SRAM Cell Design with Prescribed Power-On Data State US	US Power-On Pending	Unilled 1 <i>Dufa Stafe</i> 25-Jul-2000	60/220,700		,	
FE-00527	Solder Column Attach	Open					
FE-00527	On-Chip High Speed Termination	Open					
FE-00528	An Institute Radiation Action of Integrated Circuits	<i>ils</i> Open					
FE-00539	Visitor Information System (VIS)	Open					
FE-00540	Small Area Sidewall Rapier Contact For Chalcogenide Memory Device	genide Me.	mory Device				

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Open

EGA to CGA Conversion Process

FE-00542

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